

Notice of References Cited	Application/Control No. 10/603,845		Applicant(s)/Patent Under Reexamination TEW ET AL.	
	Examiner KEVIN L LEE		Art Unit 3753	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,913,329	06-1999	Haynes et al.	137/624.13
*	B	US-5,316,042	05-1994	Lim et al.	137/625.11
*	C	US-4,953,595	09-1990	Kotlyar	137/624.13
*	D	US-3,937,252	02-1976	Ishida	137/624.13
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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